

IN THE CLAIMS

Please cancel claims 9-27 without prejudice or disclaimer.

1. (Original) An integrated circuit inductance structure, including:
a silicon substrate;
at least one planar winding of a conductive track;
a resistive layer, not etched under the winding;
a dielectric layer between the winding and said resistive layer; and
discontinuous conductive sections, individually parallel to a closest portion of the winding, and electrically connected to ground and to said resistive layer.
2. (Original) The structure of claim 1, wherein said conductive sections are, for the most part, not arranged under projections of the winding.
3. (Original) The structure of claim 1, wherein each conductive section is placed as close as possible to the closest portion of the winding.
4. (Original) The structure of claim 1, wherein each portion of the winding is associated, along its length, to several conductive sections.
5. (Original) The structure of claim 1, wherein said conductive sections are connected to a contact point by several conductive tracks, each of the conductive tracks being arranged so that the resultant of the electromotive forces induced by the inductance is substantially null.
6. (Original) The structure of claim 5, wherein each of the conductive tracks substantially is an axis of symmetry of the inductance.
7. (Original) The structure of claim 1, wherein said conductive sections are formed in a same metallic level as a track forming an inductance.

8. (Original) The inductance structure of claim 1, wherein said resistive layer has a doping level ranging between 10^{16} and 10^{19} atoms/cm³, preferably, on the order of 10^{17} atoms/cm³.

9-27. (Canceled)